## **Claims**

What is claimed is:

- 1. A method of making a diamond tool comprising the steps of:
- a) providing a ceramic mold having an interface surface configured to inversely match a configuration intended for a working surface of the tool;
  - b) forming a thin nucleation enhancer layer on the interface surface; and
  - c) growing a diamond layer on the nucleation enhancer layer using a CVD technique, such that the working surface directly contacts the nucleation enhancer layer and receives the intended configuration from the interface surface of the mold.
  - 2. The method of claim 1, wherein the ceramic mold is made substantially of a material selected from the group consisting of oxides, nitrides, and mixtures thereof.
- The method of claim 2, wherein the oxide material is a member selected from the group consisting of: SiO<sub>2</sub>, Al<sub>2</sub>O<sub>3</sub>, LiTaO<sub>3</sub>, LiNbO<sub>3</sub>, ZnO, glass, and mixtures thereof.
  - 4. The method of claim 3, wherein the oxide material is  $Al_2O_3$ .
- 5. The method of claim 4, wherein the nitride material is a member selected from the group consisting of: Si<sub>3</sub>N<sub>4</sub>, AlN, BN, TiN, ZrN, and mixtures thereof.
  - 6. The method of claim 5, wherein the nitride material is  $Si_3N_4$ .

- 7. The method of claim 1, wherein the nucleation enhancer layer has a thickness of less than about 0.1 micrometers.
- 5 8. The method of claim 1, wherein the nucleation enhancer is made substantially of a material selected from the group consisting of: metals, metal alloys, metallic compounds, carbides, carbide formers, and mixtures thereof.
  - 9. The method of claim 8, wherein the nucleation enhancer is made substantially of a carbide former selected from the group consisting of: tungsten (W), tantalum (Ta), titanium (Ti), zirconium (Zr), chromium (Cr), silicon (Si), molybdenum (Mo) and mixture thereof.
- 10. The method of claim 8, wherein the nucleation enhancer is made substantially of a carbide selected from the group consisting of: tungsten carbide (WC), silicon carbide (SiC), titanium carbide (TiC), zirconium carbide (ZrC) and mixtures thereof.
  - 11. The method of claim 1, wherein the interface surface has a surface roughness (Ra) of less than about 1 micrometer and wherein the working surface produced receives a surface roughness (Ra) of less than about 1 micrometer.
    - 12. The method of claim 1, wherein the ceramic mold is a piezoelectric material.

13. The method of claim 12, wherein the piezoelectric material is a member selected from the group consisting of: SiO<sub>2</sub>, Si<sub>3</sub>N<sub>4</sub>, Al<sub>2</sub>O<sub>3</sub>, AlN, GaAs, GaP, LiTaO<sub>3</sub>, LiNbO<sub>3</sub>, ZnO, Pb(Zr, Ti)O<sub>3</sub>, Ta<sub>2</sub>O<sub>5</sub> Nb<sub>2</sub>O<sub>5</sub>, BeO, L<sub>2</sub>B<sub>4</sub>O<sub>7</sub>, KnbO<sub>3</sub>, ZnS, ZnSe, CdS, and mixtures thereof.

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- 14. The method of claim 12, wherein the piezoelectric material is provided from a single crystal ingot.
- 15. The method of claim 1, wherein the tool is a surface acoustic wave (SAW) filter.

- 16. The method of claim 1, further comprising the step of:
  separating the ceramic mold and nucleation enhancer layer from the diamond
  layer to expose the working surface.
- 15 17. The method of claim 16, wherein said interface surface has a concave configuration.
  - 18. The method of claim 16, wherein said interface surface has a convex configuration.
- 19. The method of claim 16, wherein said interface surface configuration inversely corresponds to the shape of a die.
  - 20. The method of claim 19, wherein said die has a channel with a non-spherical shape.

- 21. The method of claim 19, wherein the dye is a wire drawing die.
- 22. The method of claim 19, wherein the dye is an extrusion die.
- 5 23. The method of claim 16, wherein said interface surface configuration inversely corresponds to the shape of a chemical mechanical polishing (CMP) pad dresser.
  - 24. The method of claim 16, wherein said interface surface configuration inversely corresponds to the shape of a pipe.

25. The method of claim 16, wherein said interface surface configuration inversely corresponds to the shape of a diaphragm.

- 26. The method of claim 16, wherein said interface surface configuration inversely corresponds to the shape of a cutting element.
  - 27. The method of claim 26, wherein said cutting element contains chip breakers.
- 28. The method of claim 16, wherein said interface surface configuration inversely corresponds to the shape of a SAW filter.
  - 29. The method of claim 16, wherein said interface surface configuration inversely corresponds to the shape of a nozzle.

- 30. The method of claim 16, wherein step of separating is accomplished by chemically removing the mold from the diamond layer.
- 5 31. The method of claim 16, further comprising the step of forming a layer of piezoelectric material on the working surface.
  - 32. The method of claim 31, wherein the tool is a SAW filter.
- 10 34. The method of either claims 1 or 16, further comprising the step of attaching said diamond layer to a non-diamond material for incorporation into a tool.
  - 35. A method of making a diamond tool comprising the steps of:
    - a) providing a mold having an interface surface configured to inversely match a configuration intended for a working surface of the tool, said mold being made of a material selected from the group consisting of SiO<sub>2</sub>, Si<sub>3</sub>N<sub>4</sub>, Al<sub>2</sub>O<sub>3</sub>, AlN, GaAs, GaP, LiTaO<sub>3</sub>, LiNbO<sub>3</sub>, ZnO, Pb(Zr, Ti)O<sub>3</sub>, Ta<sub>2</sub>O<sub>5</sub> Nb<sub>2</sub>O<sub>5</sub>, BeO, L<sub>2</sub>B<sub>4</sub>O<sub>7</sub>, KnbO<sub>3</sub>, ZnS, ZnSe, CdS, and mixtures thereof;
  - b) forming a thin nucleation enhancer layer on the interface surface, said nucleation enhancer being made of a material selected from the group consisting of tungsten (W), tantalum (Ta), titanium (Ti), zirconium (Zr), chromium (Cr), silicon (Si), molybdenum (Mo), carbides thereof, and mixtures thereof;
    - c) growing a diamond layer on the nucleation enhancer layer using a CVD

5

technique, such that the working surface directly contacts the nucleation enhancer layer and receives the intended configuration from the interface surface of the mold; and

- d) chemically separating the ceramic mold and nucleation enhancer layer from the diamond layer to expose the working surface.
- 36. The method of claim 35, wherein the nucleation enhancer layer has a thickness of less than about 0.1 micrometers.
- The method of claim 36, wherein the interface surface has a surface roughness (Ra) of less than about 1 micrometer and wherein the working surface produced receives a surface roughness (Ra) of less than about 1 micrometer.
- 38. The method of claim 37, wherein the mold material is provided from a single crystal ingot.
  - 39. The method of claim 38, wherein the tool is a surface acoustic wave (SAW) filter.
  - 40. The method of claim 35, wherein said interface surface has a concave configuration.
  - 41. The method of claim 35, wherein said interface surface has a convex configuration.
  - 42. The method of claim 35, wherein said interface surface configuration inversely

corresponds to the shape of a die.

- 43. The method of claim 42, wherein the dye is a wire drawing die.
- 5 44. The method of claim 42, wherein the dye is an extrusion die.
  - 45. The method of claim 35, wherein said drawing die has a channel with a non-spherical shape.
- 10 46. The method of claim 35, wherein said interface surface configuration inversely corresponds to the shape of a chemical mechanical polishing (CMP) pad dresser.
  - 47. The method of claim 35, wherein said interface surface configuration inversely corresponds to the shape of a pipe.
  - 48. The method of claim 35, wherein said interface surface configuration inversely corresponds to the shape of a diaphragm.
- 49. The method of claim 35, wherein said interface surface configuration inversely corresponds to the shape of a cutting element.
  - 50. The method of claim 49, wherein said cutting element contains chip breakers.

- 51. A method of making a diamond tool consisting of the steps of:
  - a) providing a ceramic mold having an interface surface configured to inversely match a configuration intended for a working surface of the tool;
  - b) forming a thin nucleation enhancer layer on the interface surface;
- c) growing a diamond layer on the nucleation enhancer layer using a CVD technique, such that the working surface directly contacts the nucleation enhancer layer and receives the intended configuration from the interface surface of the mold;
  - d) polishing an outside surface of the mold; and
  - e) forming a plurality of interdigital transducers (IDT) on the outside surface.

- 52. The method of claim 51, wherein the nucleation enhancer is made substantially of a material selected from the group consisting of: metals, metal alloys, metallic compounds, carbides, carbide formers, and mixtures thereof.
- 15 53. The method of claim 52, wherein the nucleation enhancer is a carbide former selected from the group consisting of: tungsten (W), tantalum (Ta), titanium (Ti), zirconium (Zr), chromium (Cr), silicon (Si), molybdenum (Mo) and mixture thereof.
- 54. The method of claim 53, wherein the nucleation enhancer is a carbide selected from the group consisting of: tungsten carbide (WC), silicon carbide (SiC), titanium carbide (TiC), zirconium carbide (ZrC), and mixtures thereof.
  - 55. The method of claim 51, wherein the interface surface has a surface roughness

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(Ra) of less than about 1 micrometer and wherein the working surface produced receives a surface roughness (Ra) of less than about 1 micrometer.

- 56. The method of claim 51, wherein the ceramic mold is a piezoelectric material.
- 57. The method of claim 56, wherein the piezoelectric material is a member selected from the group consisting of: SiO<sub>2</sub>, Si<sub>3</sub>N<sub>4</sub>, Al<sub>2</sub>O<sub>3</sub>, AlN, GaAs, GaP, LiTaO<sub>3</sub>, LiNbO<sub>3</sub>, ZnO, Pb(Zr, Ti)O<sub>3</sub>, Ta<sub>2</sub>O<sub>5</sub> Nb<sub>2</sub>O<sub>5</sub>, BeO, L<sub>2</sub>B<sub>4</sub>O<sub>7</sub>, KnbO<sub>3</sub>, ZnS, ZnSe, CdS, and mixtures thereof.
- 58. The method of claim 56, wherein the piezoelectric material is provided from a single crystal ingot.
- 59. The method of claim 51, wherein the tool is a surface acoustic wave (SAW) filter.
- 60. A method of making a diamond tool consisting of the steps of:
- a) providing a mold of piezoelectric material having an interface surface with a roughness (Ra) less than about 1 nanometer, configured to inversely match a configuration intended for a working surface of the tool, said piezoelectric material being provide from a single crystal ingot selected from the group consisting of: : SiO<sub>2</sub>, Si<sub>3</sub>N<sub>4</sub>, Al<sub>2</sub>O<sub>3</sub>, AlN, GaAs, GaP, LiTaO<sub>3</sub>, LiNbO<sub>3</sub>, ZnO, Pb(Zr, Ti)O<sub>3</sub>, Ta<sub>2</sub>O<sub>5</sub> Nb<sub>2</sub>O<sub>5</sub>, BeO, L<sub>2</sub>B<sub>4</sub>O<sub>7</sub>, KnbO<sub>3</sub>, ZnS, ZnSe, CdS, and mixtures thereof;

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- b) forming a thin nucleation enhancer layer on the interface surface, said nucleation enhancer being made of a material selected from the group consisting of: tungsten (W), tantalum (Ta), titanium (Ti), zirconium (Zr), chromium (Cr), silicon (Si), molybdenum (Mo), carbides thereof, and mixtures thereof;
- c) growing a diamond layer on the nucleation enhancer layer using a CVD technique, such that the working surface directly contacts the nucleation enhancer layer and receives the intended configuration from the interface surface of the mold;
- d) polishing an outside surface of the mold; and
- e) forming a plurality of interdigital transducers (IDT) on the outside surface.
- 61. A method of making a diamond tool comprising the steps of:
  - a) providing a carbide mold having an interface surface configured to inversely match a configuration intended for a working surface of the tool; and
- b) growing a diamond layer on the interface surface using a CVD technique, such that the working surface directly contacts the interface surface and receives the intended configuration from the interface surface of the mold.
- 62. The method of claim 61, further comprising the step of: separating the carbide mold from the diamond layer to expose the working surface.
- 63. The method of claim 61, wherein the carbide is a member selected from the group consisting of: tungsten carbide (WC), silicon carbide (SiC), titanium carbide (TiC),

- 64. The method of claim 61, wherein the interface surface has a surface roughness (Ra) of less than about 1 micrometer and wherein the working surface produced receives a surface roughness (Ra) of less than about 1 micrometer.
  - 65. The method of claim 61, wherein the carbide is piezoelectric.
- 10 66. The method of claim 65, wherein the tool is a SAW filter.
  - 67. A method of making a diamond tool consisting of the steps of:
    - a) providing a carbide mold having an interface surface configured to inversely match a configuration intended for a working surface of the tool;
- b) growing a diamond layer on the interface surface using a CVD technique, such that the working surface directly contacts the interface surface and receives the intended configuration from the interface surface of the mold;
  - c) polishing an outside surface of the mold; and
  - d) forming a plurality of interdigital transducers (IDT) on the outside surface.

- 68. A method of making a diamond tool comprising the steps of:
  - a) providing a nitride mold having an interface surface configured to

inversely match a configuration intended for a working surface of the tool; and

b) growing a diamond layer on the interface surface using a CVD technique, such that the working surface receives the intended configuration from the interface surface of the mold.

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- 69. The method of claim 68, further comprising the step of:
  separating the nitride mold from the diamond layer to expose the working surface.
- 70. The method of claim 68, wherein the nitride material is a member selected from the group consisting of: Si<sub>3</sub>N<sub>4</sub>, AlN, BN, TiN, ZrN, and mixtures thereof.
  - 71. The method of claim 68, wherein the interface surface has a surface roughness (Ra) of less than about 1 micrometer and wherein the working surface produced receives a surface roughness (Ra) of less than about 1 micrometer.

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- 72. The method of claim 68, wherein the nitride layer is provide as a single crystal ingot.
- 73. The method of claim 68, wherein the tool is a SAW filter.

- 74. A method of making a diamond tool consisting of the steps of:
  - a) providing a nitride mold having an interface surface configured to inversely match a configuration intended for a working surface of the tool;

- b) growing a diamond layer on the interface surface using a CVD technique, such that the working surface directly contacts the interface surface and receives the intended configuration from the interface surface of the mold;
  - c) polishing an outside surface of the mold; and
- 5 d) forming a plurality of interdigital transducers (IDT) on the outside surface.
  - 75. A surface acoustic wave filter comprising:
    - a) a diamond layer;
    - b) a thin nucleation enhancer layer disposed on the diamond layer; and
- 10 c) a piezoelectric layer disposed on the nucleation enhancer layer.